

Search Notes

Application/Control No.

10/510,905

Examiner

Marc S. Zimmer

Applicant(s)/Patent under
Reexamination

FUJIBAYASHI ET AL.

Art Unit

1712

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR